

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/764,152	DUDECK ET AL.
	Examiner Tan T. Nguyen	Art Unit 2827

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
365	94	11/28/2005	TNT
365	104	11/28/2005	TNT
365	203	11/28/2005	TNT
365/230.03		11/28/2005	TNT